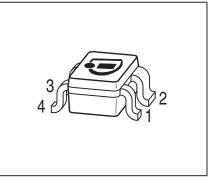


## High Performance NPN Bipolar RF Transistor

- High performance low noise amplifier
- Low minimum noise figure of typ. 0.8 dB @ 1.8 GHz
- For a wide range of non automotive applications such as WLAN, WiMax, UWB, Bluetooth, GPS, SDARs, DAB, LNB, UMTS/LTE and ISM bands
- Easy to use standard package with visible leads
- Pb-free (RoHS compliant) package





ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration						Package
BF776	R3s	1=B	2=E	3=C	4=E	-	-	SOT343

# **Maximum Ratings** at $T_A$ = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CEO</sub>		V
<i>T</i> <sub>A</sub> = 25 °C		4.0	
$T_{A} = -55 \ ^{\circ}\text{C}$		3.5	
Collector-emitter voltage	V <sub>CES</sub>	13	
Collector-base voltage	V <sub>CBO</sub>	13	
Emitter-base voltage	V <sub>EBO</sub>	1.2	
Collector current	I <sub>C</sub>	50	mA
Base current	/ <sub>B</sub>	3	
Total power dissipation <sup>1)</sup>	P <sub>tot</sub>	200	mW
$T_{\rm S} \le 90^{\circ}{\rm C}$			
Junction temperature	TJ	150	°C
Ambient temperature	T <sub>A</sub>	-55 150	
Storage temperature	T <sub>Stg</sub>	-55 150	

# ParameterSymbolValueUnitJunction - soldering point2) $R_{thJS}$ $\leq 300$ K/W

 ${}^{1}T_{S}$  is measured on the emitter lead at the soldering point to the pcb

<sup>2</sup>For calculation of  $R_{thJA}$  please refer to Application Note Thermal Resistance



Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics					
Collector-emitter breakdown voltage	V <sub>(BR)CEO</sub>	4	4.7	-	V
<i>I</i> <sub>C</sub> = 1 mA, <i>I</i> <sub>B</sub> = 0					
Collector-emitter cutoff current	I <sub>CES</sub>	-	1	-	nA
V <sub>CE</sub> = 5 V, V <sub>BE</sub> = 0					
Collector-base cutoff current	I <sub>CBO</sub>	-	1	-	
$V_{\rm CB} = 5  \text{V},  I_{\rm E} = 0$					
Emitter-base cutoff current	I <sub>EBO</sub>	-	10	-	
$V_{\rm EB}$ = 0.5 V, $I_{\rm C}$ = 0					
DC current gain	h <sub>FE</sub>	-	180	-	-
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 3 V, pulse measured					

# **Electrical Characteristics** at $T_A = 25^{\circ}C$ , unless otherwise specified

2010-04-06



Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random sampling	<b>j</b> )	1		1	1
Transition frequency	f <sub>T</sub>	-	46	-	GHz
<i>I</i> <sub>C</sub> = 30 mA, <i>V</i> <sub>CE</sub> = 3 V, <i>f</i> = 1 GHz					
Collector-base capacitance	C <sub>cb</sub>	-	0.09	-	pF
$V_{\rm CB} = 3 \text{ V}, f = 1 \text{ MHz}, V_{\rm BE} = 0$ ,					
emitter grounded					
Collector emitter capacitance	C <sub>ce</sub>	-	0.25	-	
$V_{CE} = 3 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0$ ,					
base grounded					
Emitter-base capacitance	C <sub>eb</sub>	-	0.5	-	
$V_{\rm EB} = 0.5 \text{ V}, f = 1 \text{ MHz}, V_{\rm CB} = 0$ ,					
collector grounded					
Noise figure	F				dB
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 3 V, f = 1.8 GHz, $Z_{\rm S}$ = $Z_{\rm Sopt}$		-	0.8	-	
$I_{\rm C}$ = 5 mA, $V_{\rm CE}$ = 3 V, f = 6 GHz, $Z_{\rm S}$ = $Z_{\rm Sopt}$		-	1.3	-	
Power gain, maximum stable <sup>1)</sup>	G <sub>ms</sub>	-	24	-	dB
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$ ,					
$Z_{\rm L} = Z_{\rm Lopt}$ , $f = 1.8  {\rm GHz}$					
Power gain, maximum available <sup>1)</sup>	G <sub>ma</sub>	-	12.5	-	dB
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm Sopt}$ ,					
$Z_{\rm L} = Z_{\rm Lopt}, f = 6  {\rm GHz}$					
Transducer gain	S <sub>21e</sub>   <sup>2</sup>				dB
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm L}$ = 50 $\Omega$ ,					
<i>f</i> = 1.8 GHz		-	21.5	-	
<i>f</i> = 6 GHz		-	11	-	
Third order intercept point at output <sup>2)</sup>	IP <sub>3</sub>	-	28	-	dBm
$V_{CE} = 3 \text{ V}, I_{C} = 30 \text{ mA}, Z_{S} = Z_{L} = 50 \Omega, f = 1.8 \text{ GHz}$					
1dB Compression point at output	P <sub>-1dB</sub>	-	13	-	]
$I_{\rm C}$ = 30 mA, $V_{\rm CE}$ = 3 V, $Z_{\rm S}$ = $Z_{\rm L}$ =50 $\Omega$ , $f$ = 1.8 GHz					

Electrical Characteristics of T	- 25°C unloss	othonwise specified
<b>Electrical Characteristics</b> at T <sub>1</sub>	x = 25 C. unless	otherwise specified

 ${}^{1}G_{\mathsf{ma}} = |S_{21e} / S_{12e}| \; (\mathsf{k}\text{-}(\mathsf{k}^2\text{-}1)^{1/2}), \; G_{\mathsf{ms}} = |S_{21e} / S_{12e}|$ 

<sup>2</sup>IP3 value depends on termination of all intermodulation frequency components.

Termination used for this measurement is  $50\Omega$  from 0.1 MHz to 6 GHz



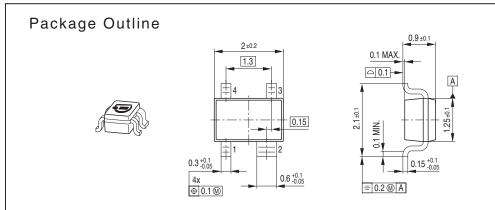
#### **SPICE Parameter**

For the SPICE model as well as for S-parameters (including noise parameters) please refer to our internet website <u>www.infineon.com/rf.models</u>.

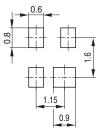
Please consult our website and download the latest versions before actually starting your design.

The simulation data have been generated and verified using typical devices. The BF776 SPICE model reflects the typical DC- and RF-performance with high accuracy.

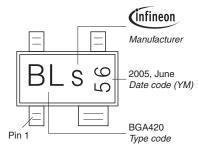




## Foot Print

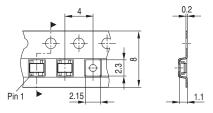


Marking Layout (Example)



### Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel







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